

<b>Notice of References Cited</b>	Application/Control No. 10/620,691		Applicant(s)/Patent Under Reexamination MIYATA ET AL.	
	Examiner Long P. Nguyen		Art Unit 2616	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2007/0094412	04-2007	Sollee, Patrick N.	709/245
*	C	US-6,160,876	12-2000	Moss et al.	379/142.02
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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